

1.1 Scope.

This specification covers the detail requirements for a quad precision, low input current, low offset voltage, monolithic bipolar amplifier.

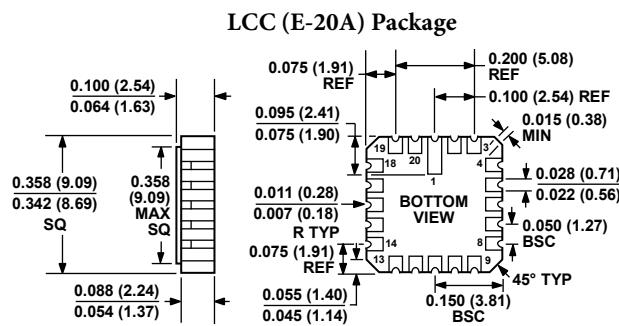
1.2 Part Number.

The complete part number per Table 1 of this specification is as follows:

Part Number

AD704SE/883B

1.2.3 Case Outline.



CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS
(IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR
REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

022108-A

(X)	Package	Description
E	E-20A	20-Terminal Leadless Chip Carrier

1.3 Absolute Maximum Ratings ($T_A = +25^\circ\text{C}$, unless otherwise noted).

Supply Voltage	$\pm 18 \text{ V}$
Internal Power Dissipation ¹	650 mW
Input Voltage	$\pm V_S$
Differential Input Voltage ²	$\pm 0.7 \text{ V}$
Output Short-Circuit Duration.....	Indefinite
Storage Temperature Range.....	-65°C to $+150^\circ\text{C}$
Operating Temperature Range.....	-55°C to $+125^\circ\text{C}$
Lead Temperature Range (Soldering 60 sec).....	300°C

¹ Maximum package power dissipation vs. ambient temperature.

Package Type	MAXIMUM AMBIENT	DERATE ABOVE MAXIMUM
	Temperature for Rating	Ambient Temperature
LCC (E-20A)	90°C	5.7 mW/°C

² The input pins of this amplifier are protected by back-to-back diodes. If the differential voltage exceeds $\pm 0.7 \text{ V}$, external series protection resistors should be added to limit the input current to less than 25 mA.

1.4 Thermal Characteristics.

Thermal Resistance:	$\theta_{JC} = 25^\circ\text{C}/\text{W}$ for E-20A Package
	$\theta_{JC} = 95^\circ\text{C}/\text{W}$ for E-20A Package

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Table 1.

Test	Symbol	Sub Group	Limits		Unit	Test Conditions ¹
			Min	Max		
Input Offset Voltage	V _{OS}	1		150	μV	
		2, 3		250		
Power Supply Rejection Ratio	PSRR	1	100		dB	±2 V ≤ V _S ≤ ±18 V
		2, 3	100			±2.5 V ≤ V _S ≤ ±18 V
Input Bias Current ²	I _B	1		270	pA	Either input, V _{CM} = 0 V
		2, 3		600		
		1		300	pA	Either input, V _{CM} = ±13.5 V
		2, 3		700		
Input Offset Current	I _{OS}	1		250	pA	V _{CM} = 0 V
		2, 3		400		
		1		300	pA	V _{CM} = ±13.5 V
		2, 3		500		
Matching Characteristics	V _{OS}				μV	
		1		250		
	I _B	2, 3		400		
		1		500		
	CMR	2, 3		600		
		1, 2, 3		94		
Common-Mode Rejection ⁴	PSR	1, 2, 3		94	dB	
		1, 2, 3		94		
Common-Mode Rejection Ratio	CMRR	1	100		dB	V _{CM} = ±13.5 V
		2, 3	98			
Open-Loop Gain	A _{OL}	1	200		V/mV	V _O = ±12 V, R _L = 10 kΩ
		2, 3	150			
		1	200		V/mV	V _O = ±10 V, R _L = 2 kΩ
		2, 3	100			
Output Voltage Swing	V _{OUT}	1, 2, 3	±13		V	R _L = 10 kΩ
Power Supply Quiescent Current	I _Q	1		2.5	mA	
		2, 3		2.8		

¹ V_S = ±15 V, unless otherwise noted.² Bias current specifications maximum at either input.³ Input bias current match is the maximum difference between the corresponding inputs of all four amplifiers.⁴ CMR match is the difference between ΔV_{OS}/ΔV_{CM} for any two amplifiers, expressed in dB.⁵ PSR match is the difference between ΔV_{OS}/ΔV_{SUPPLY} for any two amplifiers, expressed in dB.